

DATA SHEET

74ALS573B/74ALS574A Latch flip-flop

Product specification
IC05 Data Handbook

1991 Feb 08

Latch/flip-flop

74ALS573B/74ALS574A

74ALS573B Octal transparent latch (3-State)
 74ALS574A Octal D flip-flop (3-State)

FEATURES

- 74ALS573B is broadside pinout version of 74ALS373
- 74ALS574A is broadside pinout version of 74ALS374
- Inputs and outputs on opposite side of package allow easy interface to microprocessors
- Useful as an input or output port for microprocessors
- 3-State outputs for bus interfacing
- Common output enable
- 74ALS563A and 74ALS564A are inverting version of 74ALS573B and 74ALS574A respectively

DESCRIPTION

The 74ALS573B is an octal transparent latch coupled to eight 3-State output devices. The two sections of the device are controlled independently by enable (E) and output enable (\overline{OE}) control gates.

The 74ALS573B is functionally identical to the 74ALS373 but has a broadside pinout configuration to facilitate PC board layout and allow easy interface with microprocessors.

The data on the D inputs is transferred to the latch outputs when the enable (E) input is High. The latch remains transparent to the data input while E is High, and stores the data that is present one setup time before the High-to-Low enable transition.

The 74ALS574A is functionally identical to the 74ALS374 but has a broadside pinout configuration to facilitate PC board layout and allow easy interface with microprocessors.

It is an 8-bit edge triggered register coupled to eight 3-State output buffers. The two sections of the device are controlled independently by clock (CP) and output enable (\overline{OE}) control gates.

The register is fully edge triggered. The state of the D input, one setup time before the Low-to-High clock transition is transferred to the corresponding flip-flop's Q output.

The active-Low output enable (\overline{OE}) controls all eight 3-State buffers independent of the latch operation. When \overline{OE} is Low, latched or transparent data appears at the output.

When \overline{OE} is High, the outputs are in high impedance "off" state, which means they will neither drive nor load the bus.

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74ALS573B	5.0ns	12mA
74ALS574A	6.0ns	15mA

ORDERING INFORMATION

DESCRIPTION	ORDER CODE	DRAWING NUMBER
	COMMERCIAL RANGE $V_{CC} = 5V \pm 10\%$, $T_{amb} = 0^{\circ}C \text{ to } +70^{\circ}C$	
20-pin plastic DIP	74ALS573BN, 74ALS574AN	SOT146-1
20-pin plastic SOL	74ALS573BD, 74ALS574AD	SOT163-1
20-pin plastic SSOP Type II	74ALS573BDB, 74ALS574ADB	SOT339-1

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

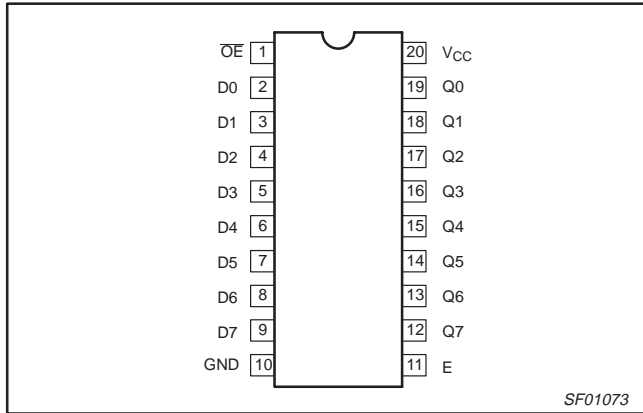
PINS	DESCRIPTION	74ALS (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
D0 – D7	Data inputs	1.0/1.0	20 μ A/0.2mA
E (74ALS573B)	Latch enable input	1.0/1.0	20 μ A/0.1mA
\overline{OE}	Output Enable input (active-Low)	1.0/1.0	20 μ A/0.1mA
CP (74ALS574A)	Clock pulse input (active rising edge)	1.0/2.0	20 μ A/0.2mA
Q0 – Q7	Data outputs	130/240	2.6mA/24mA

NOTE: One (1.0) ALS unit load is defined as: 20 μ A in the High state and 0.1mA in the Low state.

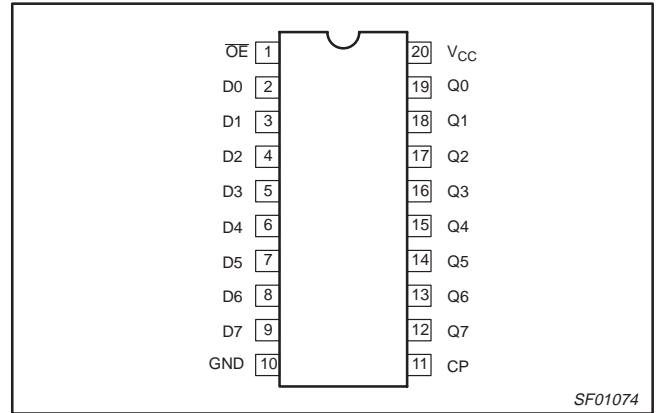
Latch/flip-flop

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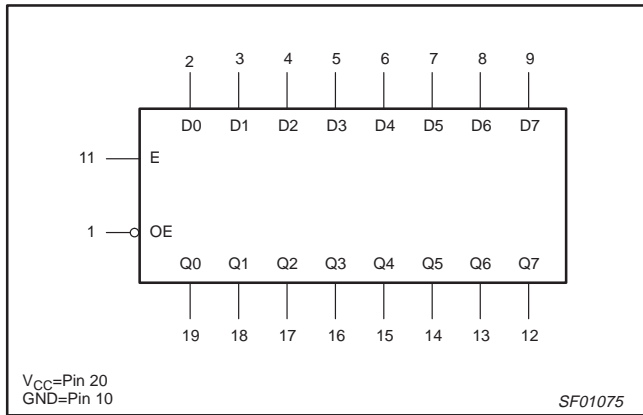
PIN CONFIGURATION – 74ALS573B



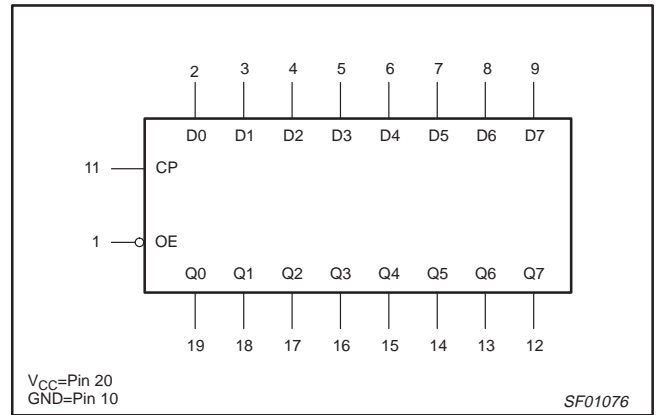
PIN CONFIGURATION – 74ALS574A



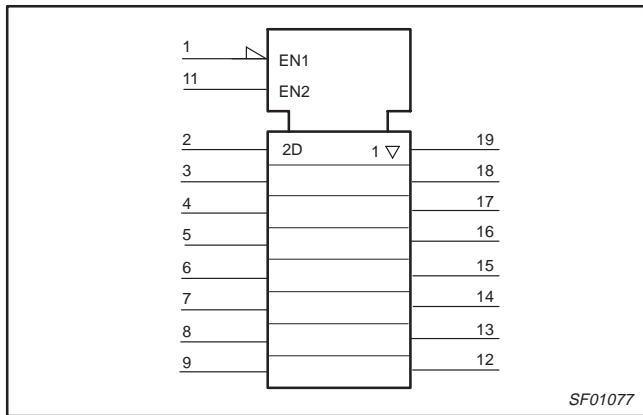
LOGIC SYMBOL – 74ALS573B



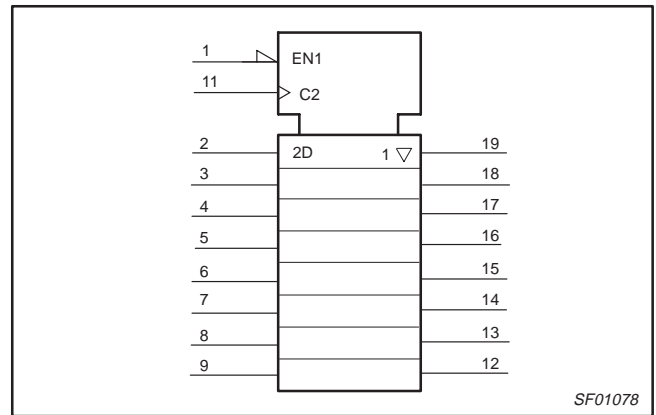
LOGIC SYMBOL – 74ALS574A



IEC/IEEE SYMBOL – 74ALS573B



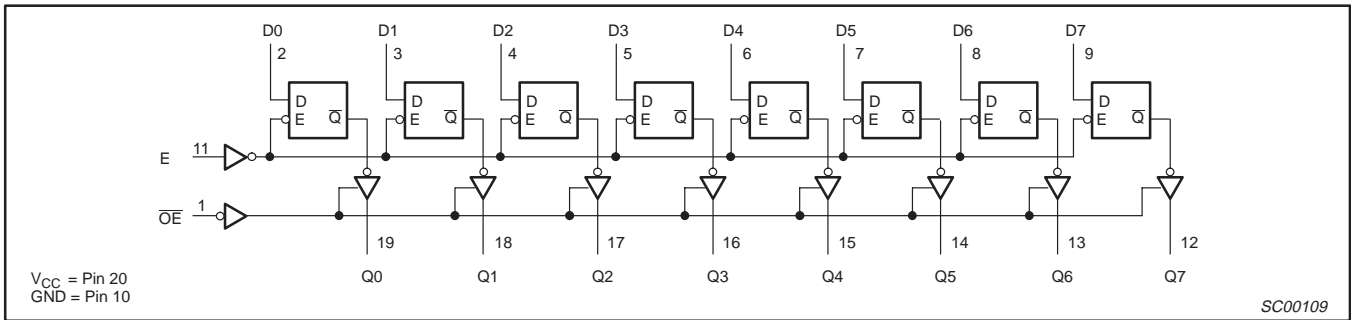
IEC/IEEE SYMBOL – 74ALS574A



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LOGIC DIAGRAM – 74ALS573B

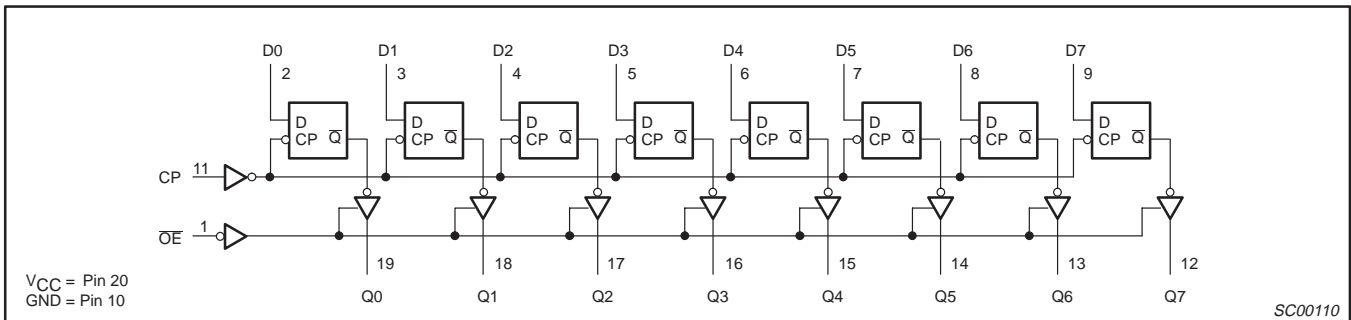


FUNCTION TABLE – 74ALS573B

INPUTS			OUTPUTS REGISTER	INTERNAL	OPERATING MODE
\overline{OE}	E	D _n		Q0 – Q7	
L	H	L	L	L	Enable and read register
L	H	H	H	H	
L	↓	l	L	L	Latch and read register
L	↓	h	H	H	
L	L	X	NC	NC	Hold
H	L	X	NC	Z	Disable outputs
H	H	D _n	D _n	Z	

- H = High-voltage level
- h = High state must be present one setup time before the High-to-Low enable transition
- L = Low-voltage level
- l = Low state must be present one setup time before the High-to-Low enable transition
- NC = No change
- X = Don't care
- Z = High impedance "off" state
- ↓ = High-to-Low enable transition

LOGIC DIAGRAM – 74ALS574A



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FUNCTION TABLE – 74ALS574A

INPUTS			OUTPUTS REGISTER	INTERNAL	OPERATING MODE
\overline{OE}	CP	Dn		Q0 – Q7	
L	\uparrow	l	L	L	Latch and read register
L	\uparrow	h	H	H	
L	\uparrow	X	NC	NC	Hold
H	\uparrow	X	NC	Z	Disable outputs
H	\uparrow	Dn	Dn	Z	

H = High-voltage level

h = High state must be present one setup time before the Low-to-High clock transition

L = Low-voltage level

l = Low state must be present one setup time before the Low-to-High clock transition

NC= No change

X = Don't care

Z = High impedance "off" state

 \uparrow = Low-to-High clock transition \uparrow = Not Low-to-High clock transition

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limit set forth in this table may impair the useful life of the device.)

Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V_{CC}	Supply voltage	-0.5 to +7.0	V
V_{IN}	Input voltage	-0.5 to +7.0	V
I_{IN}	Input current	-30 to +5	mA
V_{OUT}	Voltage applied to output in High output state	-0.5 to V_{CC}	V
I_{OUT}	Current applied to output in Low output state	48	mA
T_{amb}	Operating free-air temperature range	0 to +70	°C
T_{stg}	Storage temperature range	-65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS			UNIT
		MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5.0	5.5	V
V_{IH}	High-level input voltage	2.0			V
V_{IL}	Low-level input voltage			0.8	V
I_{IK}	Input clamp current			-18	mA
I_{OH}	High-level output current			-2.6	mA
I_{OL}	Low-level output current			24	mA
T_{amb}	Operating free-air temperature range	0		+70	°C

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DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER		TEST CONDITIONS ¹	LIMITS			UNIT		
				MIN	TYP ²	MAX			
V _{OH}	High-level output voltage		V _{CC} = ±10%, V _{IL} = MAX, V _{IH} = MIN	I _{OH} = -0.4mA	V _{CC} - 2		V		
				I _{OH} = MAX	2.4	3.2	V		
V _{OL}	Low-level output voltage		V _{CC} = MIN, V _{IL} = MAX, V _{IH} = MIN	I _{OL} = 12mA		0.25	0.40	V	
				I _{OL} = 24mA		0.35	0.50	V	
V _{IK}	Input clamp voltage		V _{CC} = MIN, I _I = I _{IK}		-0.73	-1.2	V		
I _I	Input current at minimum input voltage		V _{CC} = MAX, V _I = 7.0V			0.1	mA		
I _{IH}	High-level input current		V _{CC} = MAX, V _I = 2.7V			20	μA		
I _{IL}	Low-level input current	74ALS573B	V _{CC} = MAX, V _I = 0.4V			-0.1	mA		
		74ALS574A	V _{CC} = MAX, V _I = 0.4V			-0.2	mA		
I _{OZH}	Off-state output current, High-level voltage applied		V _{CC} = MAX, V _I = 2.7V			20	μA		
I _{OZL}	Off-state output current, Low-level voltage applied		V _{CC} = MAX, V _I = 0.4V			-20	μA		
I _O	Output current ³		V _{CC} = MAX, V _O = 2.25V	-30		-112	mA		
I _{CC}	Supply current (total)		74ALS573B	I _{CCH}	V _{CC} = MAX	7	12	mA	
				I _{CCL}		13	21	mA	
				I _{CCZ}		15	24	mA	
			74ALS574A	I _{CCH}		V _{CC} = MAX	10	16	mA
				I _{CCL}			17	27	mA
				I _{CCZ}			18	28	mA

NOTES:

- For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
- All typical values are at V_{CC} = 5V, T_{amb} = 25°C.
- The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}.

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AC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITION	LIMITS		UNIT	
			$T_{amb} = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V \pm 10\%$ $C_L = 50pF, R_L = 500\Omega$			
			MIN	MAX		
t_{PLH} t_{PHL}	Propagation delay Dn to Qn	74ALS573B	Waveform 3	2.0 2.0	10.0 10.0	ns
t_{PLH} t_{PHL}	Propagation delay E to Qn		Waveform 2	4.0 4.0	12.0 12.0	ns
t_{PZH} t_{PZL}	Output enable time to High or Low level		Waveform 6 Waveform 7	2.0 4.0	9.0 11.0	ns
t_{PHZ} t_{PLZ}	Output disable time from High or Low level		Waveform 6 Waveform 7	1.0 2.0	9.0 11.0	ns
f_{MAX}	Maximum clock frequency	74ALS574A	Waveform 1	45		MHz
t_{PLH} t_{PHL}	Propagation delay CP to Qn		Waveform 1	3.0 4.0	12.0 12.0	ns
t_{PZH} t_{PZL}	Output enable time to High or Low level		Waveform 6 Waveform 7	2.0 4.0	9.0 11.0	ns
t_{PHZ} t_{PLZ}	Output disable time from High or Low level		Waveform 6 Waveform 7	1.0 2.0	9.0 11.0	ns

AC SETUP CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITION	LIMITS		UNIT	
			$T_{amb} = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V \pm 10\%$ $C_L = 50pF, R_L = 500\Omega$			
			MIN	MAX		
$t_{su(H)}$ $t_{su(L)}$	Setup time, High or Low Dn to E	74ALS573B	Waveform 4	6.0 6.0		ns
$t_h(H)$ $t_h(L)$	Hold time, High or Low Dn to E		Waveform 4	6.0 6.0		ns
$t_w(H)$	E Pulse width, High		Waveform 1	10.0		ns
$t_{su(H)}$ $t_{su(L)}$	Setup time, High or Low Dn to CP	74ALS574A	Waveform 5	6.0 6.0		ns
$t_h(H)$ $t_h(L)$	Hold time, High or Low Dn to CP		Waveform 5	1.0 1.0		ns
$t_w(H)$ $t_w(L)$	CP Pulse width, High or Low		Waveform 5	8.0 12.0		ns

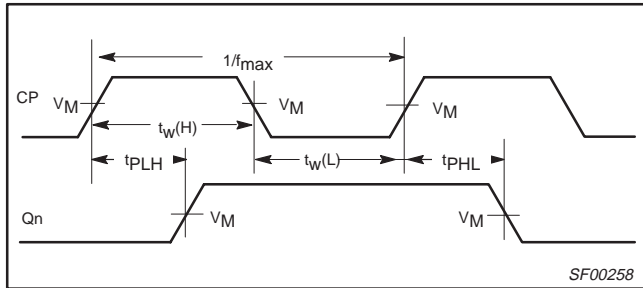
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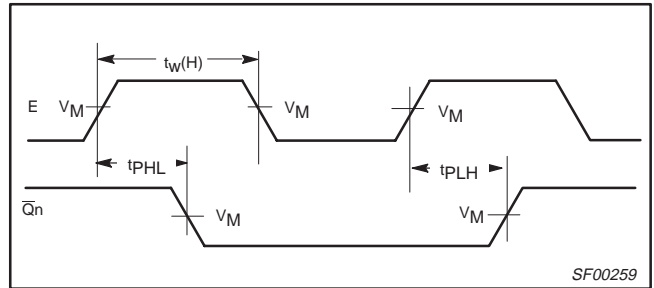
AC WAVEFORMS

For all waveforms, $V_M = 1.3V$.

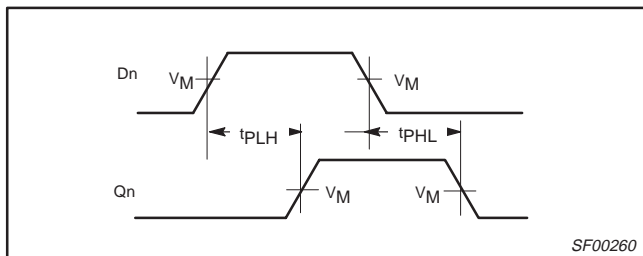
The shaded areas indicate when the input is permitted to change for predictable output performance.



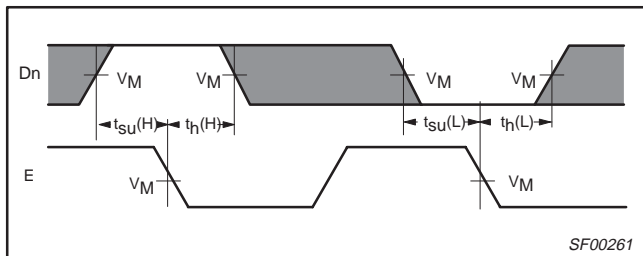
Waveform 1. Propagation Delay for Clock Input to Output, Clock Pulse Widths, and Maximum Clock Frequency



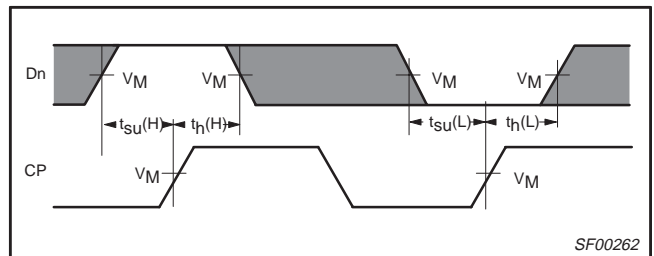
Waveform 2. Propagation Delay for Enable to Output and Enable Pulse Width



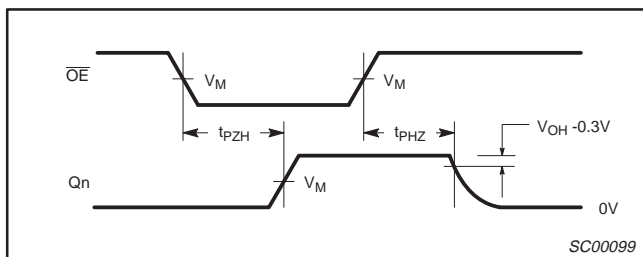
Waveform 3. Propagation Delay for Data to Output



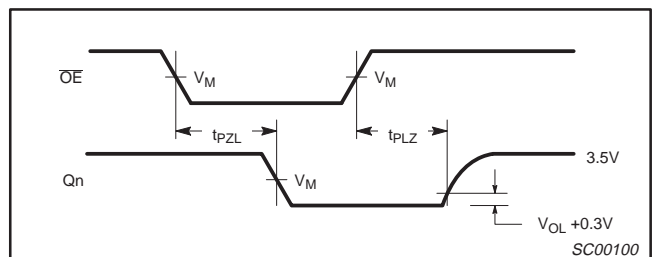
Waveform 4. Data Setup Time and Hold Times



Waveform 5. Data Setup Time and Hold Times



Waveform 6. 3-State Output Enable Time to High Level and Output Disable Time from High Level

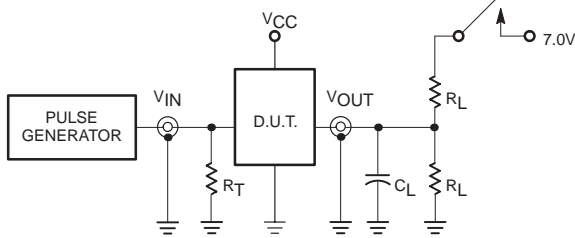


Waveform 7. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level

Latch/flip-flop

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TEST CIRCUIT AND WAVEFORMS



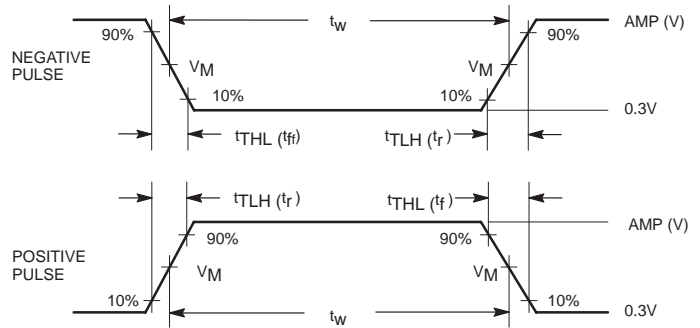
Test Circuit for 3-State Outputs

SWITCH POSITION

TEST	SWITCH
t_{PLZ} , t_{PZL}	closed
All other	open

DEFINITIONS:

- R_L = Load resistor; see AC electrical characteristics for value.
- C_L = Load capacitance includes jig and probe capacitance; see AC electrical characteristics for value.
- R_T = Termination resistance should be equal to Z_{OUT} of pulse generators.



Input Pulse Definition

Family	INPUT PULSE REQUIREMENTS					
	Amplitude	V_M	Rep.Rate	t_w	t_{TLH}	t_{THL}
74ALS	3.5V	1.3V	1MHz	500ns	2.0ns	2.0ns

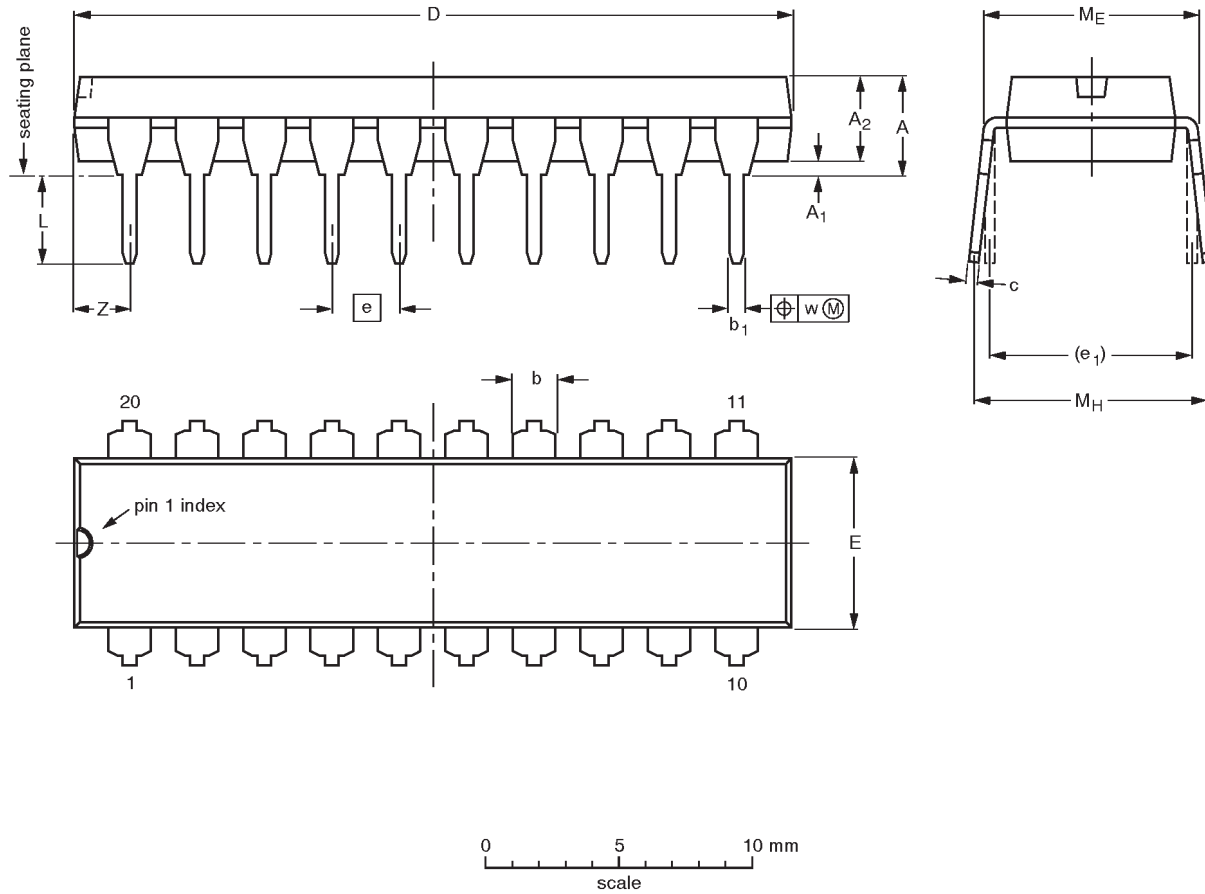
SC00072

Latch/flip-flop

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DIP20: plastic dual in-line package; 20 leads (300 mil)

SOT146-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	c	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	M _E	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	0.36 0.23	26.92 26.54	6.40 6.22	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.0
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.014 0.009	1.060 1.045	0.25 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.078

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

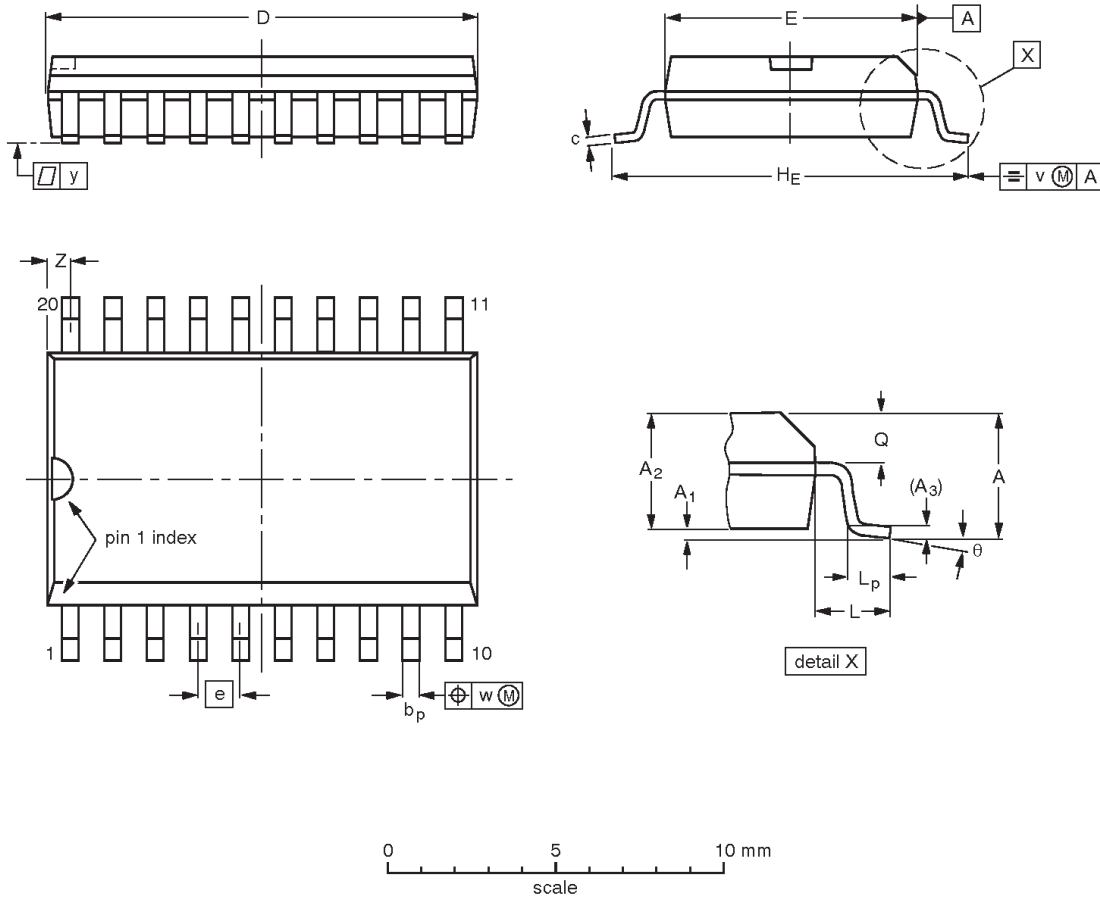
OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT146-1			SC603			92-11-17 95-05-24

Latch/flip-flop

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SO20: plastic small outline package; 20 leads; body width 7.5 mm

SOT163-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	b _p	c	D ⁽¹⁾	E ⁽¹⁾	e	H _E	L	L _p	Q	v	w	y	Z ⁽¹⁾	θ
mm	2.65	0.30 0.10	2.45 2.25	0.25	0.49 0.36	0.32 0.23	13.0 12.6	7.6 7.4	1.27	10.65 10.00	1.4	1.1 0.4	1.1 1.0	0.25	0.25	0.1	0.9 0.4	8° 0°
inches	0.10	0.012 0.004	0.096 0.089	0.01	0.019 0.014	0.013 0.009	0.51 0.49	0.30 0.29	0.050	0.42 0.39	0.055	0.043 0.016	0.043 0.039	0.01	0.01	0.004	0.035 0.016	

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

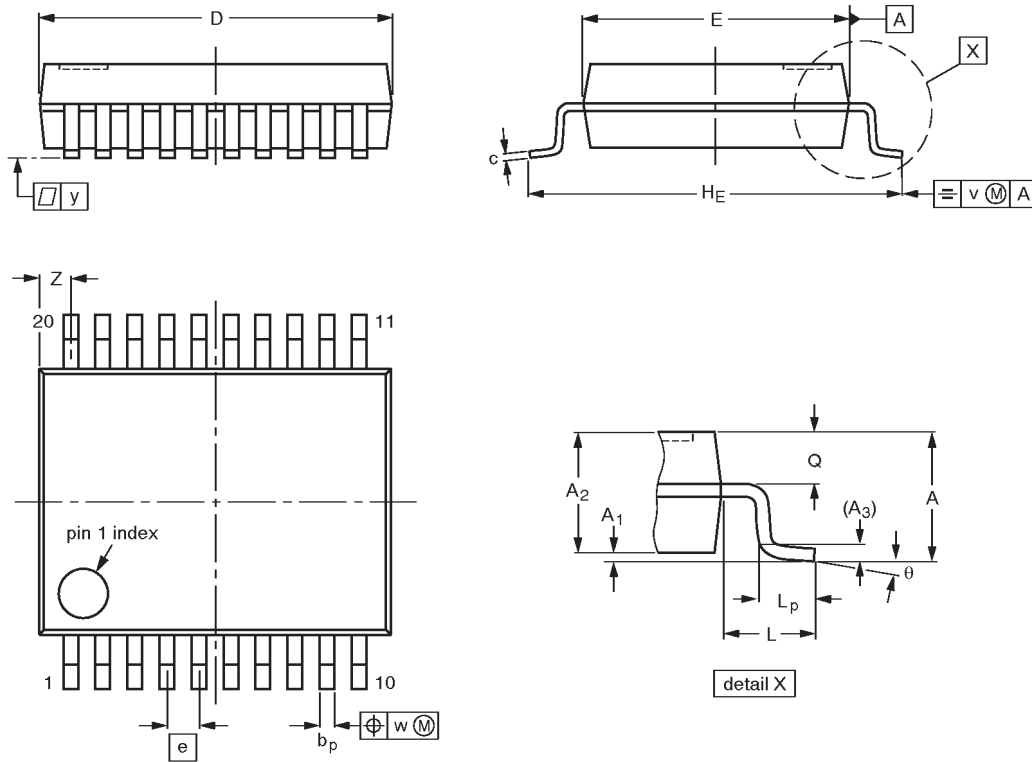
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	IEC	JEDEC	EIAJ			
SOT163-1	075E04	MS-013AC				92-11-17 95-01-24

Latch/flip-flop

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SSOP20: plastic shrink small outline package; 20 leads; body width 5.3 mm

SOT339-1



DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	b _p	c	D ⁽¹⁾	E ⁽¹⁾	e	H _E	L	L _p	Q	v	w	y	Z ⁽¹⁾	θ
mm	2.0	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	7.4 7.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	0.9 0.5	8° 0°

Note

1. Plastic or metal protrusions of 0.20 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT339-1		MO-150AE				93-09-08 95-02-04

Latch/flip-flop

74ALS573B/74ALS574A

DEFINITIONS

Data Sheet Identification	Product Status	Definition
<i>Objective Specification</i>	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.
<i>Preliminary Specification</i>	Preproduction Product	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
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